Search Notes

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Application/Control	No.	
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Applicant(s)/Patent under Reexamination

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ANDIDEH ET AL.
Art Unit

Examiner

Jung (John) H. Hur

2824

SEARCHED				
Class	Subclass	Date	Examiner	
365	51, 63, 65, 145, 130, 163, 117	12/13/2006	JH	
365	113, 109	12/13/2006	JH	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
365	63, 51	12/13/2006	JH	
365	65, 145	12/13/2006	JH	
365	163	12/13/2006	JH	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST IEEE Google Scholar	12/12/2006	JH	